IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicant:

Tatsuya USAMI

Appl. No.:

NEW NON-PROVISIONAL

Group:

Filed:

January 28, 2004

Examiner:

For:

SEMICONDUCTOR DEVICE WITH IMPROVED

RELIABILITY AND MANUFACTURING METHOD OF

THE SAME

INFORMATION DISCLOSURE STATEMENT
(SUBMISSION CONCURRENT WITH THE
FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

January 28, 2004

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

				patents								
since	the	USPTO	has	waived	the	ir	submi	ssion	for	app	licat	ions
filed	afte:	r June	30,	2003.								

- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

III. CONCISE EXPLANATION OF THE RELEVANCE (check at least one box) DOCUMENTS IN THE ENGLISH LANGUAGE a. The attached patents, publications, or other information in the English language do not require a statement of relevancy. \bowtie b. DOCUMENTS NOT IN THE ENGLISH LANGUAGE A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows: Cited on pages 3, 7, 8, and 9 of the present specification \Box FOREIGN SEARCH REPORT OR ACTION c. An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying requirement for a the explanation. See MPEP 609(A)(3). OTHER d. П The following additional information is provided for the Examiner's consideration. FEES This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required. If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned. Respectfully submitted, YOUNG & THOMPSON Genorit Castel Benoit Castel, Reg. No. 35,041 745 South 23rd Street Arlington, VA 22202 Telephone (703) 521-2297 BC/ma

Form PTO-1449(s)

Foreign Search Report

Documents

Other:____

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Enclosures:

INFO	DRMATION DISCLOSURI	E CITATION	Attorney Docket No.: 8022-1067		Application No.: NEW NONPROVISIONA						
	IN AN APPLICATIO	N	Applicant: Tatsuya USAMI								
	(Use several sheets if necess	sary)	Filing Date: January 28, 2004		Group Art Unit:						
		U.S. PATEN	T DOCUMENTS								
Examine Initial	er Document Number	Date	Name	Class	Subclass	Filing date (if appropriate)					
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		FOREIGN PAT	ENT DOCUMENTS		<u> </u>						
Examiner Initial	Document Number	Date	Country	Clas	s Subclass		slation				
	2003-17561	1/17/2003	JAPAN			Yes	No				
	11-87502	3/30/1999	JAPAN								
	2000-294634 2001-326222	10/20/2000	JAPAN JAPAN			<u> </u>					
	2002-246383	8/30/2002	JAPAN								
						 					
	OTHER DOCUMEN	TS (Including Au	thor, Title, Date, Pertine	nt Pages	Etc.)		L				
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^{*} Abstract provided for the Examiner's convenience